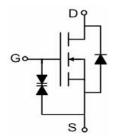


Description

The AP2N7002A uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a

Battery protection or in other Switching application.

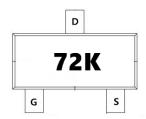


General Features

 $V_{DS} = 60V I_{D} = 0.3A$

 $R_{DS(ON)} < 3\Omega$ @ $V_{GS}=10V$

ESD Rating: HBM≥2000V



Application

Battery protection

Load switch

Uninterruptible power supply



Package Marking and Ordering Information

999			
Product ID	Pack	Marking	Qty(PCS)
AP2N7002A	SOT-23		3000

Absolute Maximum Ratings (T_C=25°Cunless otherwise noted)

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	60	V	
Gate-Source Voltage		V _G s	±20	V	
	T _A =25℃		0.3		
Continuous Drain Current (T _J =150℃)	T _A =100℃	- I _D	0.19	A	
Drain Current-Pulsed (Note 1)		Ідм	0.8	А	
Maximum Power Dissipation		Po	0.35	W	
Operating Junction and Storage Temperature Range		TJ,Tstg	-55 To 150	°C	
Thermal Resistance, Junction-to-Ambient (Note 2)		Reja	350	°C/W	



Electrical Characteristics (T_A=25 ℃ unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250µA	60	68	-	V
Zero Gate Voltage Drain Current	IDSS	V _{DS} =60V,V _{GS} =0V	-	-	1	μΑ
Gate-Body Leakage Current	Igss	V _{GS} =±10V,V _{DS} =0V	-	±100	±500	nA
		V _{GS} =±20V,V _{DS} =0V	-	±4	±10	uA
Gate Threshold Voltage	VGS(th)	V _{DS} =V _{GS} ,I _D =250µA	0.7	1.2	1.9	V
		V _{GS} =5V, I _D =0.4A	-	1.3	3	Ω
Drain-Source On-State Resistance	Rds(on)	V _{GS} =10V, I _D =0.5A	-	1	2	Ω
Forward Transconductance	grs	V _{DS} =10V,I _D =0.2A	0.1	-	-	S
Input Capacitance	Clss		-	21	50	PF
Output Capacitance	Coss	V _{DS} =25V,V _{GS} =0V, F=1.0MHz	-	11	25	PF
Reverse Transfer Capacitance	Crss	1 – 1.01011 12	-	4.2	5	PF
Turn-on Delay Time	td(on)		-	10	-	nS
Turn-on Rise Time	tr	V _{DD} =30V,I _D =0.2A	-	50	-	nS
Turn-Off Delay Time	td(off)	V _{GS} =10V,R _{GEN} =10Ω	-	17	-	nS
Turn-Off Fall Time	t _f		-	10	-	nS
		V _{DS} =10V,I _D =0.3A,				
Total Gate Charge	Qg	V _{GS} =4.5V	-	1.7	3	nC
Diode Forward Voltage (Note 3)	VsD	V _{GS} =0V,I _S =0.2A	-	-	1.2	V
Diode Forward Current (Note 2)	Is		-	-	0.3	Α

Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production



Typical Electrical And Thermal Characteristics

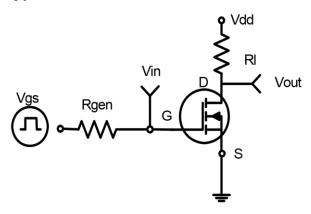


Figure 1:Switching Test Circuit

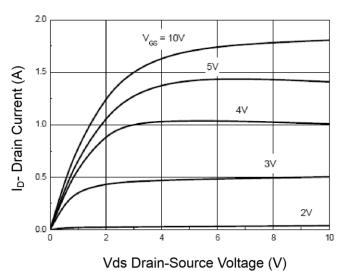


Figure 3 Output Characteristics

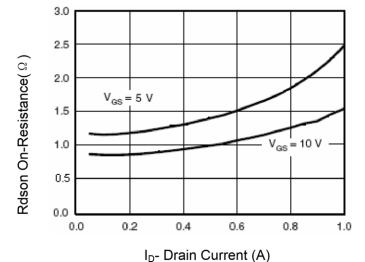


Figure 5 Drain-Source On-Resistance

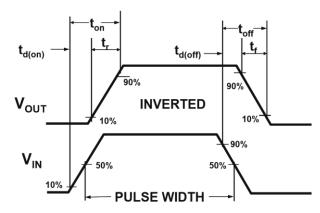


Figure 2:Switching Waveforms

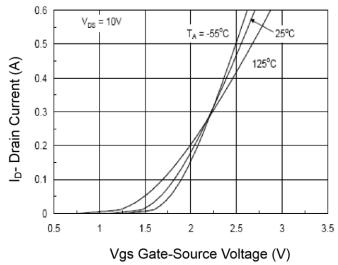
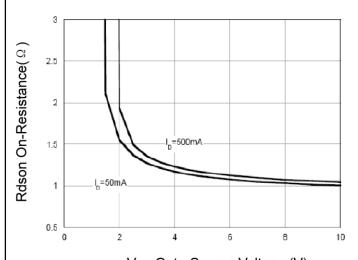


Figure 4 Transfer Characteristics

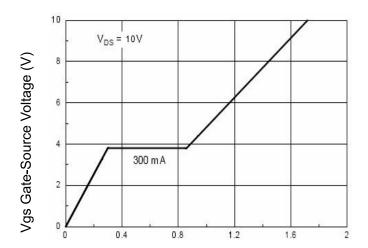


Vgs Gate-Source Voltage (V)
Figure 6 Rdson vs Vgs

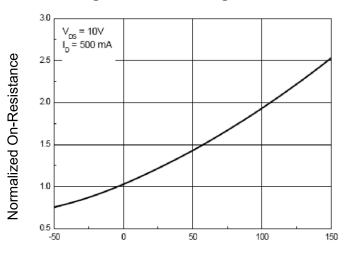


AP2N7002A

60V N-Channel Enhancement Mode MOSFET



Qg Gate Charge (nC) Figure 7 Gate Charge



 T_J -Junction Temperature(${}^{\circ}$ C) Figure 9 Drain-Source On-Resistance

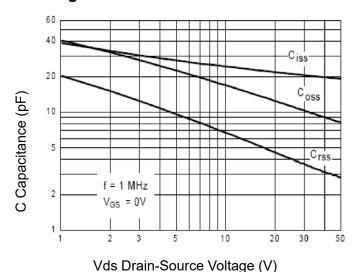


Figure 11 Capacitance vs Vds

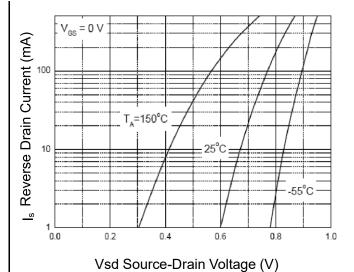
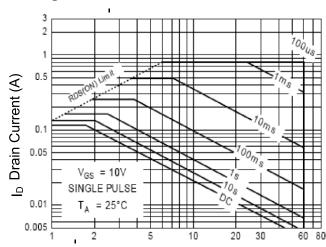


Figure 8 Source-DrainDiode Forward



Vds Drain-Source Voltage (V)
Figure 10 Safe Operation Area



AP2N7002A

60V N-Channel Enhancement Mode MOSFET

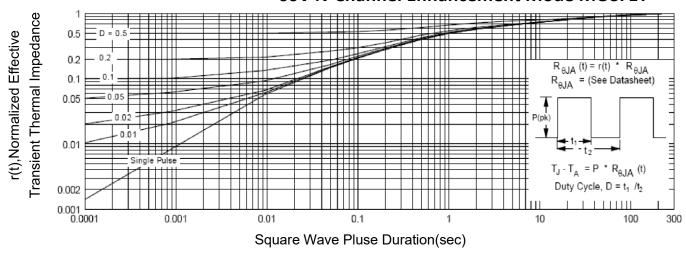
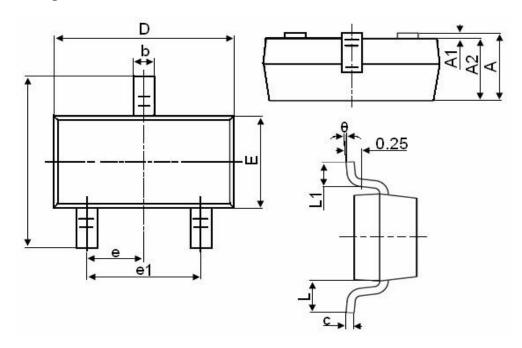


Figure 12 Normalized Maximum Transient Thermal Impedance



SOT-23 Package Information



Symbol	Dimensions in Millimeters			
	MIN.	MAX.		
Α	0.900	1.150		
A1	0.000	0.100		
A2	0.900	1.050		
b	0.300	0.500		
С	0.080	0.150		
D	2.800	3.000		
E	1.200	1.400		
E1	2.250	2.550		
е		0.950TYP		
e1	1.800	2.000		
L		0.550REF		
L1	0.300	0.500		
θ	0°	8°		



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